

**Notice of References Cited**

Application/Control No.

10/750,436

Applicant(s)/Patent Under  
Reexamination  
DEB ET AL.

Examiner

MARK A. FLEISCHER

Art Unit

3623

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,177,859 B2	02-2007	Pather et al.	707/3
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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